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Relevance scale **1** [Fast detection of communication patterns in distributed executions](#)

Thomas Kunz, Michiel F. H. Seuren

November 1997 **Proceedings of the 1997 conference of the Centre for Advanced Studies on Collaborative research**Full text available:  [pdf\(4.21 MB\)](#) Additional Information: [full citation](#), [abstract](#), [references](#), [index terms](#)

Understanding distributed applications is a tedious and difficult task. Visualizations based on process-time diagrams are often used to obtain a better understanding of the execution of the application. The visualization tool we use is Poet, an event tracer developed at the University of Waterloo. However, these diagrams are often very complex and do not provide the user with the desired overview of the application. In our experience, such tools display repeated occurrences of non-trivial commun ...

**2** [Programming languages for distributed computing systems](#)

Henri E. Bal, Jennifer G. Steiner, Andrew S. Tanenbaum

September 1989 **ACM Computing Surveys (CSUR)**, Volume 21 Issue 3Full text available:  [pdf\(6.50 MB\)](#) Additional Information: [full citation](#), [abstract](#), [references](#), [citations](#), [index terms](#), [review](#)

When distributed systems first appeared, they were programmed in traditional sequential languages, usually with the addition of a few library procedures for sending and receiving messages. As distributed applications became more commonplace and more sophisticated, this ad hoc approach became less satisfactory. Researchers all over the world began designing new programming languages specifically for implementing distributed applications. These languages and their history, their underlying pr ...

**3** [Compositional verification of concurrent systems using Petri-net-based condensation rules](#)

Eric Y. T. Juan, Jeffrey J. P. Tsai, Tadao Murata

September 1998 **ACM Transactions on Programming Languages and Systems (TOPLAS)**, Volume 20 Issue 5Full text available:  [pdf\(578.81 KB\)](#) Additional Information: [full citation](#), [abstract](#), [references](#), [citations](#), [index terms](#)

The state-explosion problem of formal verification has obstructed its application to large-scale software systems. In this article, we introduce a set of new condensation theories: IOT-failure equivalence, IOT-state equivalence, and firing-dependence theory to cope with


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Relevance scale **1 Reliable object storage to support atomic actions**

Brian M. Oki, Barbara H. Liskov, Robert W. Scheifler

December 1985 **ACM SIGOPS Operating Systems Review, Proceedings of the tenth ACM symposium on Operating systems principles**, Volume 19 Issue 5Full text available:  [pdf\(939.13 KB\)](#) Additional Information: [full citation](#), [references](#), [citations](#), [index terms](#)**2 Principles of transaction-oriented database recovery**

Theo Haerder, Andreas Reuter

December 1983 **ACM Computing Surveys (CSUR)**, Volume 15 Issue 4Full text available:  [pdf\(2.48 MB\)](#) Additional Information: [full citation](#), [references](#), [citations](#), [index terms](#), [review](#)**3 Implementation of resilient, atomic data types**

William Weihl, Barbara Liskov

April 1985 **ACM Transactions on Programming Languages and Systems (TOPLAS)**, Volume 7 Issue 2Full text available:  [pdf\(2.19 MB\)](#) Additional Information: [full citation](#), [abstract](#), [references](#), [citations](#), [index terms](#), [review](#)

A major issue in many applications is how to preserve the consistency of data in the presence of concurrency and hardware failures. We suggest addressing this problem by implementing applications in terms of abstract data types with two properties: Their objects are atomic (they provide serializability and recoverability for activities using them) and resilient (they survive hardware failures with acceptably high probability). We define what it means for abstract data types to be atomic and ...

**4 A model for concurrency in nested transactions systems**

Catriel Beeri, Philip A. Bernstein, Nathan Goodman

April 1989 **Journal of the ACM (JACM)**, Volume 36 Issue 2Full text available:  [pdf\(3.73 MB\)](#) Additional Information: [full citation](#), [abstract](#), [references](#), [citations](#), [index terms](#), [review](#)

Today's standard model for database concurrency control, called serializability theory, represents executions of transactions as partial orders of operations. The theory tells when an execution is serializable, that is, when the set of operations of a transaction execute

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**1 Atomic broadcast in asynchronous crash-recovery distributed system**

*Rodrigues, L.; Raynal, M.;*

Distributed Computing Systems, 2000. Proceedings. 20th International Conference, 10-13 April 2000

Pages:288 - 295

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**2 Atomic broadcast in asynchronous crash-recovery distributed system and its use in quorum-based replication**

*Rodrigues, L.; Raynal, M.;*

Knowledge and Data Engineering, IEEE Transactions on, Volume: 15, Issue: 5, Sept.-Oct. 2003

Pages:1206 - 1217

[\[Abstract\]](#) [\[PDF Full-Text \(1842 KB\)\]](#) **IEEE JNL**

**3 Probabilistic atomic broadcast**

*Felber, P.; Pedone, F.;*

Reliable Distributed Systems, 2002. Proceedings. 21st IEEE Symposium on, Oct. 2002

Pages:170 - 179

[\[Abstract\]](#) [\[PDF Full-Text \(590 KB\)\]](#) **IEEE CNF**

**4 Consensus-based fault-tolerant total order multicast**

*Fritzke, U., Jr; Ingels, P.; Mostefaoui, A.; Raynal, M.;*

Parallel and Distributed Systems, IEEE Transactions on, Volume: 12, Issue: 2, Feb. 2001

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